

### OSA20N60S / OSK20N60S 600V N-Channel MOSFET

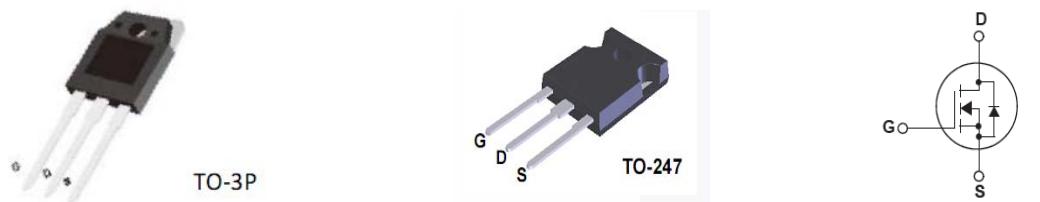
#### Description

SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.

This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.

#### Features

- 650V @ $T_J = 150^\circ\text{C}$
- Typ.  $R_{DS(on)} = 0.16\Omega$
- Ultra Low Gate Charge (typ.  $Q_g = 63\text{nC}$ )
- 100% avalanche tested
- RoHS Compliant



#### Absolute Maximum Ratings

Symbol	Parameter	OSA-K20N60S	Unit
$V_{DSS}$	Drain-Source Voltage	600	V
$I_D$	Drain Current -Continuous ( $TC = 25^\circ\text{C}$ ) -Continuous ( $TC = 100^\circ\text{C}$ )	20* 10*	A
$I_{DM}$	Drain Current - Pulsed (Note 1)	62*	A
$V_{GSS}$	Gate-Source voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	525	mJ
$I_{AR}$	Avalanche Current (Note 1)	20	A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	1	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ (Note 3)	4.5	V/ns
$P_D$	Power Dissipation ( $TC = 25^\circ\text{C}$ ) -Derate above $25^\circ\text{C}$	151 1.67	W W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum Lead Temperature for Soldering Purpose, $1/8"$ from Case for 5 Seconds	300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature.

#### Thermal Characteristics

Symbol	Parameter	OSA-K20N60S	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.83	$^\circ\text{C}/\text{W}$
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	$^\circ\text{C}/\text{W}$

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## Electrical Characteristics TC = 25°C unless otherwise noted

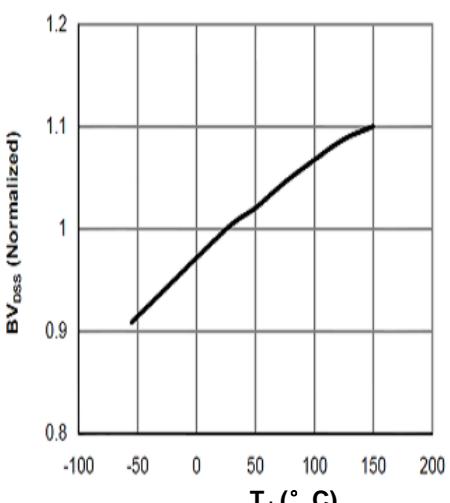
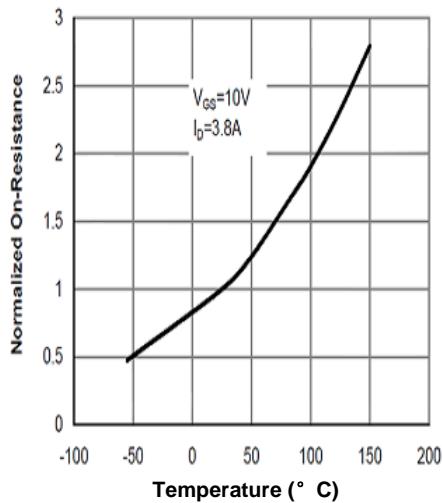
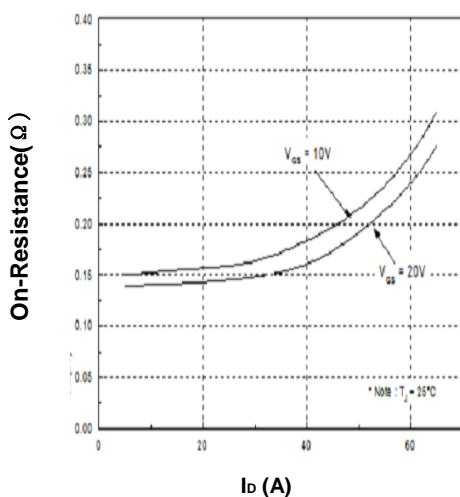
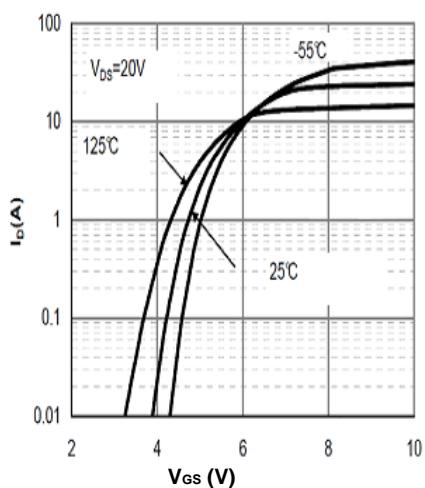
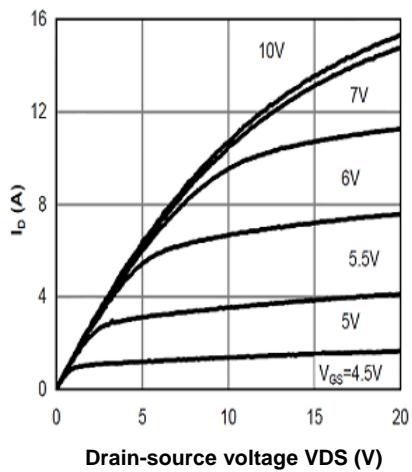
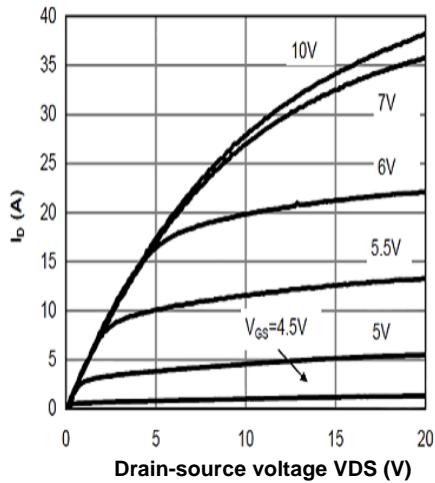
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, ID = 250µA, TJ = 25°C	600	--	--	V
		V <sub>GS</sub> = 0V, ID = 250µA, TJ = 150°C	--	650	--	V
Δ BV <sub>DSS</sub> / Δ TJ	Breakdown Voltage Temperature Coefficient	ID = 250µA, Referenced to 25°C	--	0.6	--	V/°C
ID <sub>SS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 600V, V <sub>GS</sub> = 0V V <sub>DS</sub> = 480V, TC = 125°C	--	--	1 10	µA µA
IG <sub>TSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30V, V <sub>DS</sub> = 0V	--	--	100	nA
IG <sub>SSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30V, V <sub>DS</sub> = 0V	--	--	-100	nA
<b>On Characteristics</b>						
V <sub>G(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , ID = 250µA	2.5	--	4.5	V
R <sub>D(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, ID = 10A	--	0.16	0.19	Ω
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 40V, ID = 5A (Note 4)	--	16	--	S
R <sub>g</sub>	Gate Resistance	F=1MHz, open drain	--	4.5	--	Ω
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V, f = 1.0MHz	--	1440	--	pF
C <sub>oss</sub>	Output Capacitance		--	300	--	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	10	--	pF
<b>Switching Characteristics</b>						
td(on)	Turn-On Delay Time	V <sub>DD</sub> = 400V, ID = 10A RG = 20Ω (Note 4, 5)	--	25	--	ns
tr	Turn-On Rise Time		--	55	--	ns
td(off)	Turn-Off Delay Time		--	70	--	ns
tf	Turn-Off Fall Time		--	40	--	ns
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 480V, ID = 20A V <sub>GS</sub> = 10V (Note 4, 5)	--	63	--	nC
Q <sub>gs</sub>	Gate-Source Charge		--	7.8	--	nC
Q <sub>gd</sub>	Gate-Drain Charge		--	9	--	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current	--	--	20	--	A
ISM	Maximum Pulsed Drain-Source Diode Forward Current	--	--	60	--	A
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0V, IS = 20A	--	--	1.5	V
trr	Reverse Recovery Time	V <sub>GS</sub> = 0V, IS = 20A dI/dt = 100A/µs (Note 4)	--	475	--	ns
Q <sub>rr</sub>	Reverse Recovery Charge		--	5.8	--	µC

### NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. L=10.5mH, I<sub>AS</sub>=10A, V<sub>DD</sub>=150V, Starting TJ=25 °C
3. I<sub>SD</sub>≤20A, di/dt ≤ 200A/µs, V<sub>DD</sub>≤ BV<sub>DSS</sub>, Starting TJ = 25 °C
4. Pulse Test: Pulse width ≤ 300us, Duty Cycle ≤ 2%
5. Essentially Independent of Operating Temperature Typical Characteristics

# OSA20N60S / OSK20N60S

## Typical Performance Characteristics



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## Typical Performance Characteristics

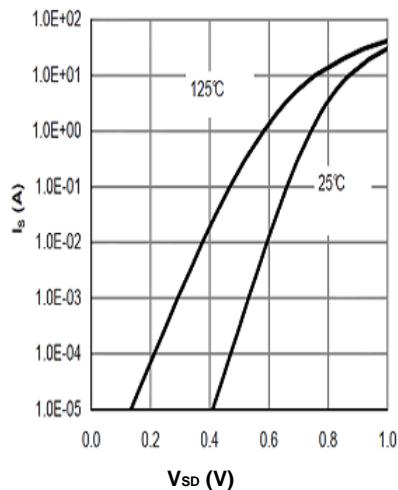


Figure 7: Body-Diode Characteristics

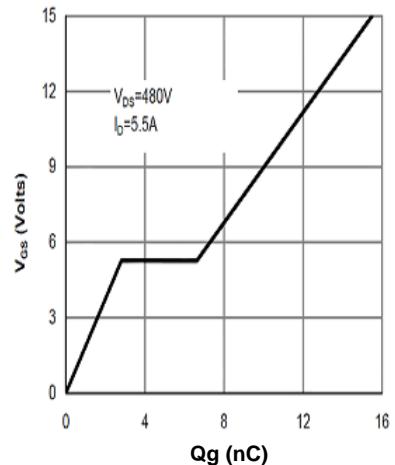


Figure 8: Gate-Charge Characteristics

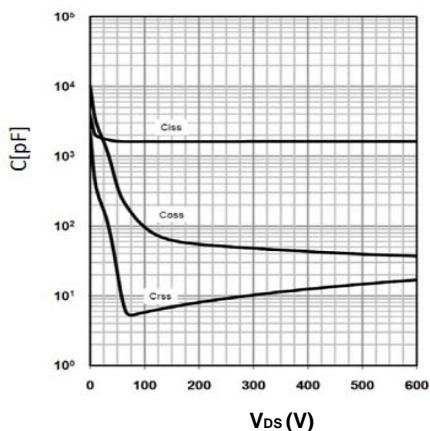


Figure 9: Capacitance Characteristics  
 $C=f(V_{DS})$ ,  $V_{GS}=0\text{V}$ ,  $f=1\text{MHz}$

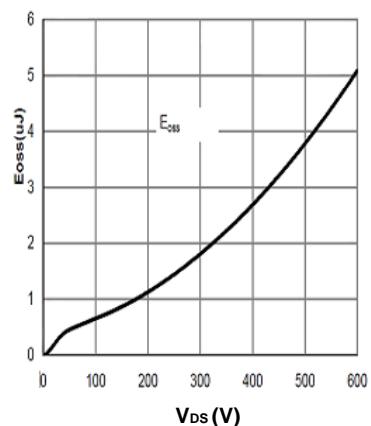


Figure 10:  $C_{oss}$  stored Energy

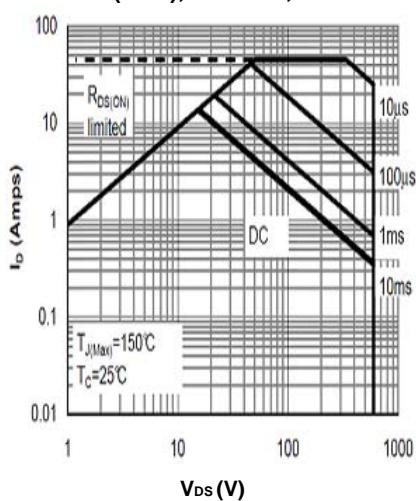


Figure 11: Maximum Forward Biased  
Safe Operating Area

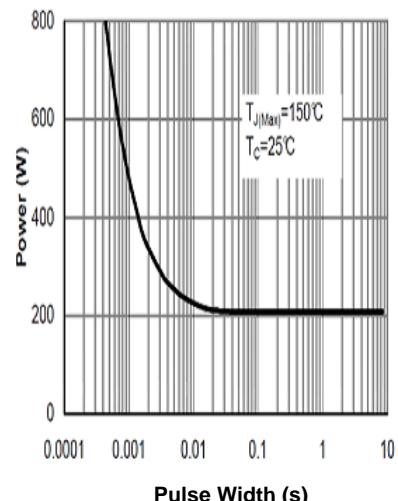


Figure 12: Single Pulse Power Rating  
Junction to Case

# OSA20N60S / OSK20N60S

## Typical Performance Characteristics

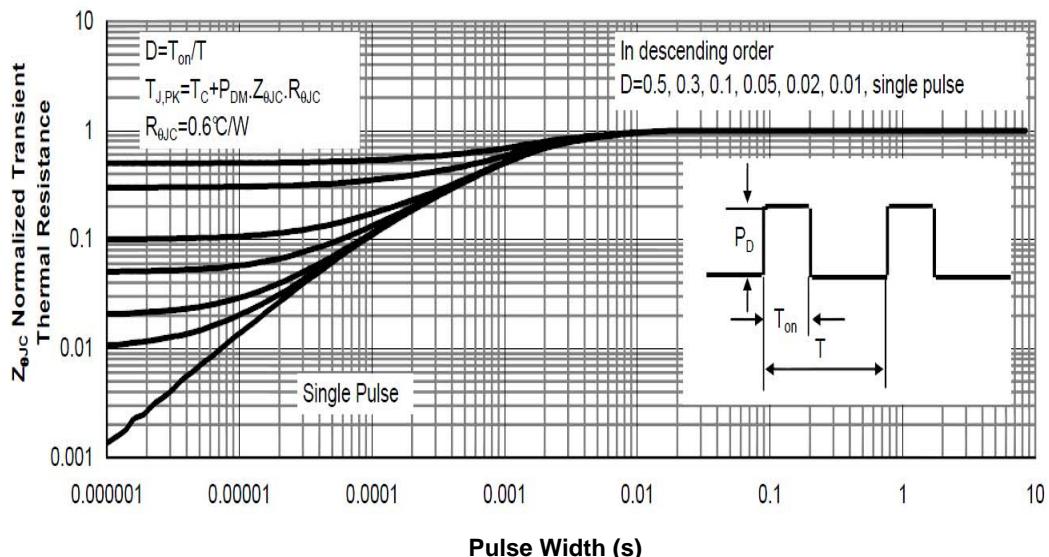


Figure 12: Normalized Maximum Transient Thermal Impedance

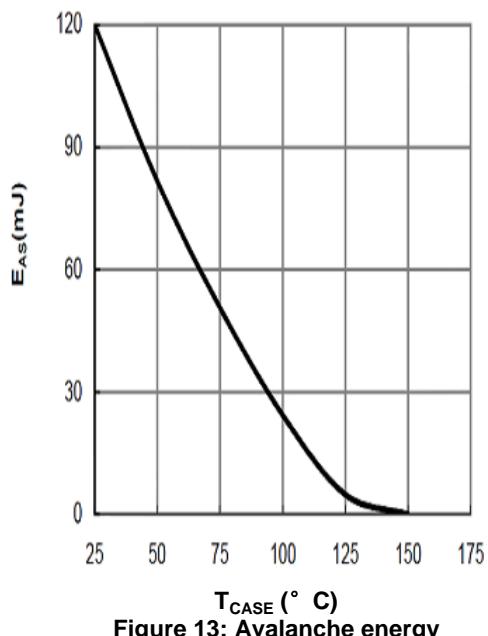


Figure 13: Avalanche energy

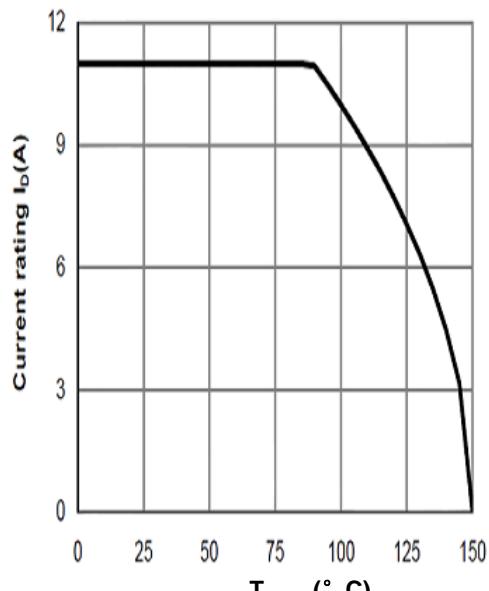


Figure 14: Current De-rating

# OSA20N60S / OSK20N60S

## Typical Performance Characteristics

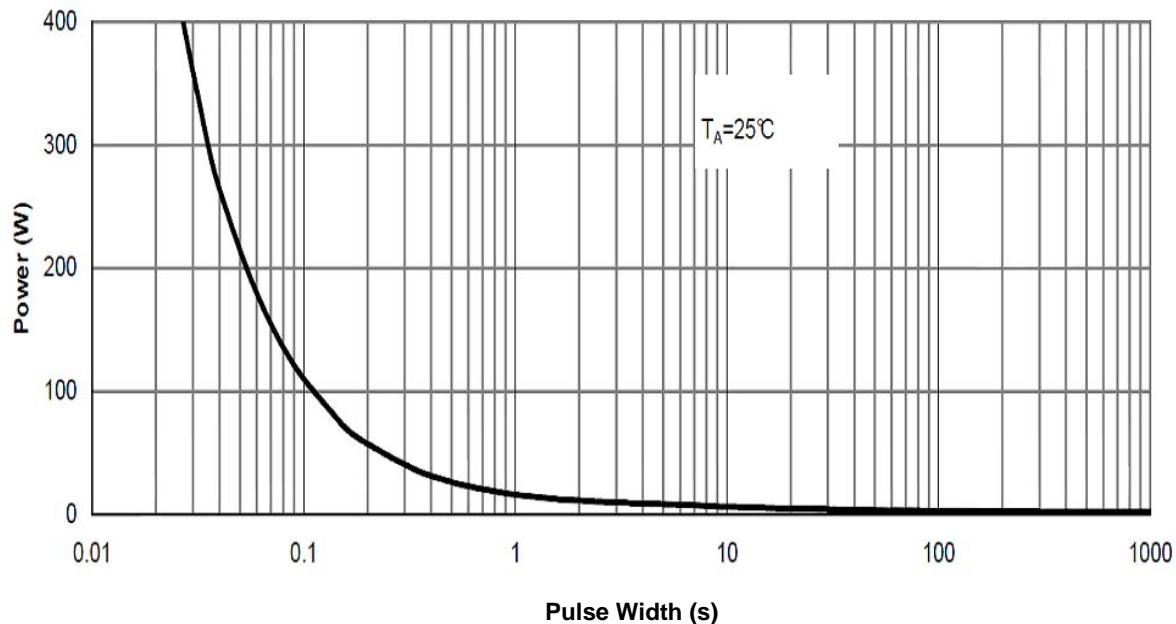


Figure 15: Single Pulse Power Rating Junction-Ambient

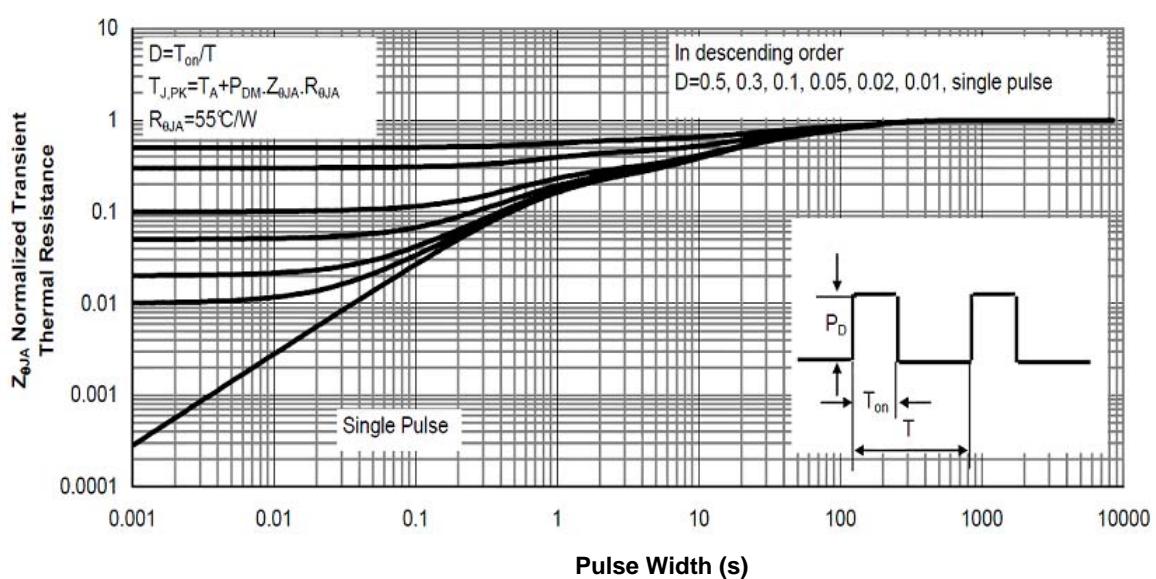


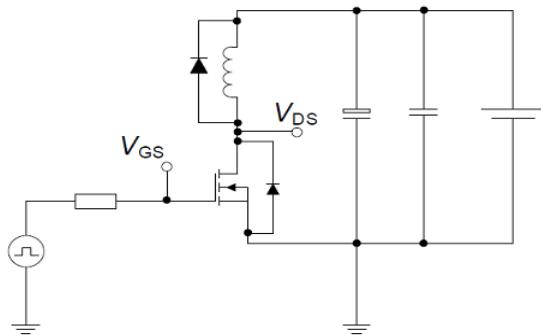
Figure 16: Normalized Maximum Transient Thermal Impedance

# OSA20N60S / OSK20N60S

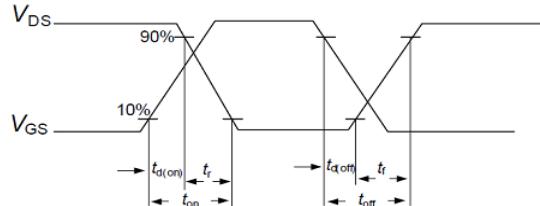
## Test circuits

Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load

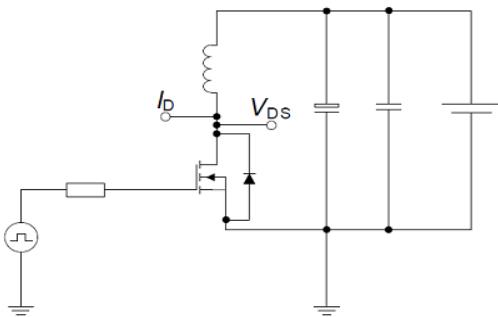


Switching time waveform

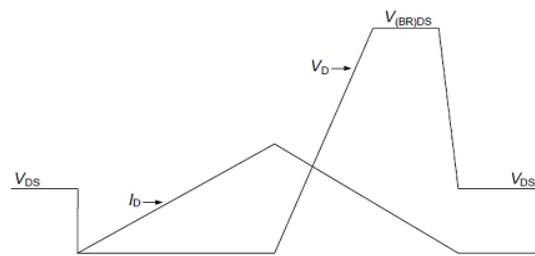


Unclamped inductive load test circuit and waveform

Unclamped inductive load test circuit

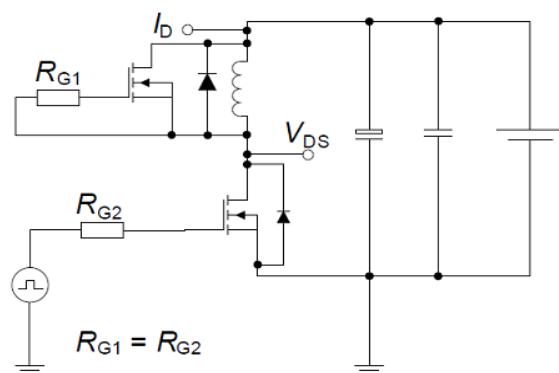


Unclamped inductive waveform

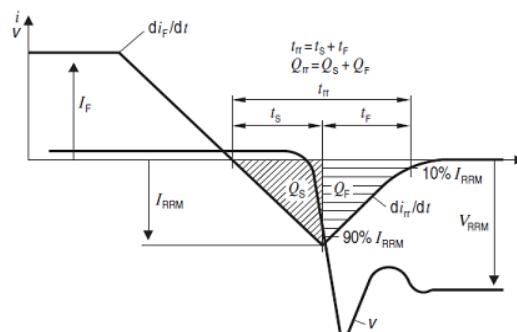


Test circuit and waveform for diode characteristics

Test circuit for diode characteristics



Diode recovery waveform



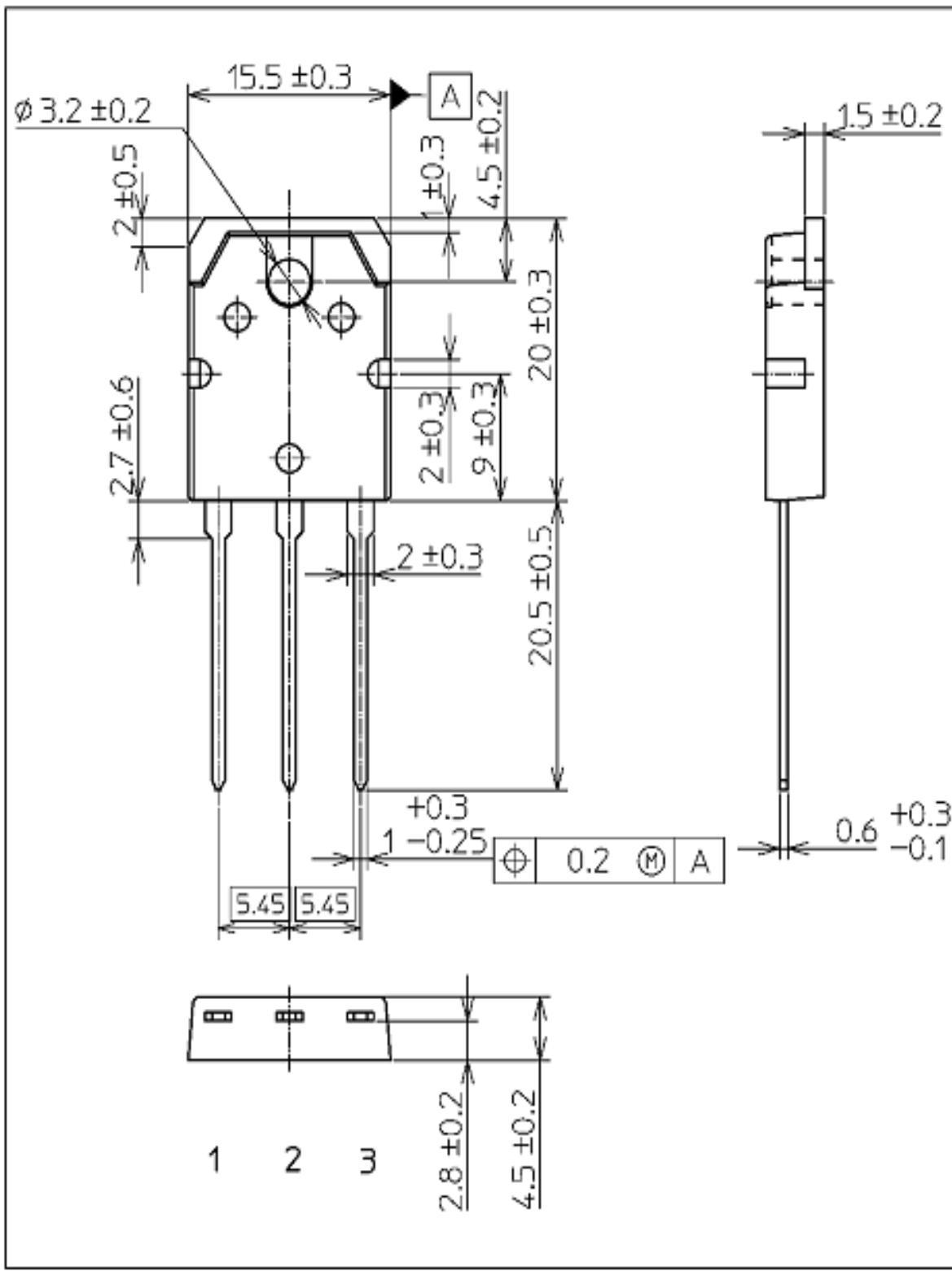
**OSA20N60S / OSK20N60S**

PKG TO-247

## **OSA20N60S / OSK20N60S**

PKG TO-3P

**Unit: mm**



# OSA20N60S / OSK20N60S

## PKG TO-247

